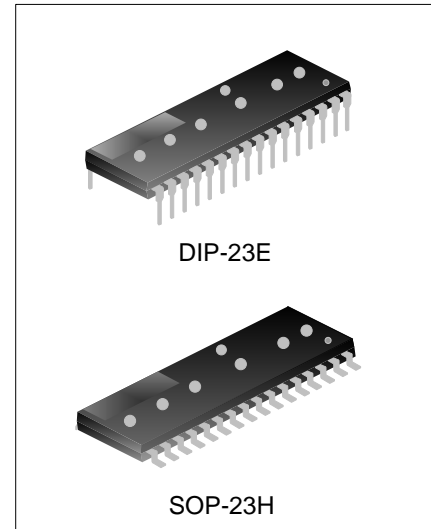


INTELLIGENT POWER MODULE(IPM), 3 PHASE FULL-BRIDGE 500V/2A

DESCRIPTION

SDM02M50DBE/DBS is a 3-phase brushless DC motor driver IC with highly-integrated and high reliability, using for small power motor drive applications such as fan motor, consisting of built-in 6 fast recovery MOSFET and 3 half-bridge HVIC for gate driving.

SDM02M50DBE/DBS integrates under-voltage protection circuit, providing perfect protection and fail-safe operation. Each phase current of inverter can be monitored separately due to divided negative dc terminals. SDM02M50DBE/DBS is designed with good insulation, perfect thermal properties and low EMI. It is compact and suitable for built-in motors or any other applications requiring the compact installation.



FEATURES

- ◆ Built-in 500V/2A fast recovery MOSFET
- ◆ Built-in high-voltage Gate driver circuit (HVIC)
- ◆ Built-in under-voltage protection
- ◆ Built-in bootstrap diode
- ◆ Compliant with 3.3V and 5V MCU interface, active high
- ◆ 3 independent negative DC-link terminals for inverter current sensing
- ◆ Optimal adapted for low EMI
- ◆ Insulation class: 1500V_{rms}/min

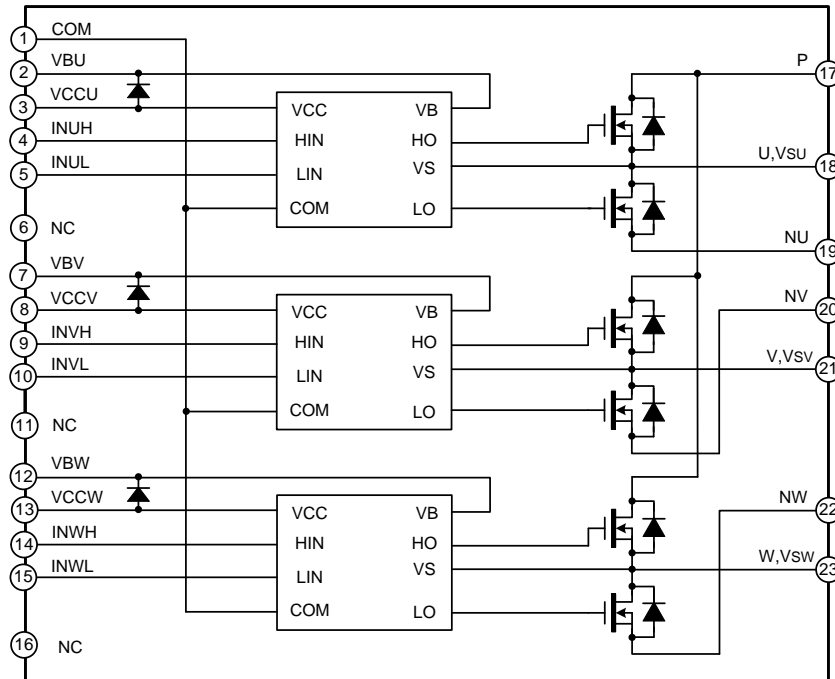
APPLICATIONS

- ◆ Indoor/outdoor air conditioner
- ◆ Refrigerator compressor
- ◆ Smoke exhauster
- ◆ Fan
- ◆ Air purifiers
- ◆ Dishwasher pump

ORDERING INFORMATION

| Part No | Package | Marking | Hazardous Substance Control | Packing Type |
|---------------|---------|-------------|-----------------------------|--------------|
| SDM02M50DBE | DIP-23E | SDM02M50DBE | Pb free | Tube |
| SDM02M50DBS | SOP-23H | SDM02M50DBS | Pb free | Tube |
| SDM02M50DBSTR | SOP-23H | SDM02M50DBS | Pb free | Tape&Reel |

BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS

| Characteristics | Symbol | Ratings | Unit |
|--|-----------------|--------------------|---------------|
| P-N Input voltage | V_{PN} | 500 | V |
| Each MOSFET Continuous Drain Current $T_C=25^{\circ}C$ | I_{D25} | 2.0 | A |
| Each MOSFET Continuous Drain Current $T_C=80^{\circ}C$ | I_{D80} | 1.5 | A |
| Each MOSFET Peak Drain Current (Peak value) $T_C=25^{\circ}C$, pulse width<100 μ s | I_{DP} | 3.0 | A |
| Maximum Power Dissipation, $T_C=25^{\circ}C$ | P_D | 13.4 | W |
| Control Supply Voltage | V_{CC} | 20 | V |
| High-side Bias Voltage | V_{BS} | 20 | V |
| Input Signal Voltage | V_{IN} | -0.3~ $V_{CC}+0.3$ | V |
| Operating Junction Temperature Range | T_J | -40~150 | $^{\circ}C$ |
| Operating Case Temperature Range, $T_J \leq 150^{\circ}C$ (Note 1) | T_C | -40~125 | $^{\circ}C$ |
| Storage Temperature Range | T_{STG} | -40~125 | $^{\circ}C$ |
| Junction to Case Thermal Resistance | $R_{\theta JC}$ | 9.3 | $^{\circ}C/W$ |
| Insulation Voltage 60Hz, Sinusoidal, AC 1 minute, Connection Pins to Heatsink | V_{ISO} | 1500 | V_{rms} |
| Bootstrap Diode Forward Current, $T_C=25^{\circ}C$ | I_F | 0.5 | A |
| Bootstrap Diode Forward Current(Peak), $T_C=25^{\circ}C$, Under 1ms Pulse Width | I_{FP} | 1.5 | A |

Note 1: Test point for Case Temperature, please see figure 3.

RECOMMENDED OPERATING CONDITIONS

| Characteristics | Symbol | Min | Typ | Max | Unit |
|--|---------------|------|-----|----------|---------|
| Supply Voltage | V_{PN} | -- | 300 | 400 | V |
| Control Supply Voltage | V_{CC} | 13.5 | 15 | 16.5 | V |
| High-side Bias Voltage | V_{BS} | 13.5 | 15 | 16.5 | V |
| Input ON Threshold Voltage | $V_{IN(ON)}$ | 3.0 | -- | V_{CC} | V |
| Input OFF Threshold Voltage | $V_{IN(OFF)}$ | 0 | -- | 0.8 | V |
| Dead Time for Preventing Arm-short $V_{CC}=V_{BS}=13.5\sim 16.5V, T_J \leq 150^\circ C$ | T_{dead} | 1.0 | -- | -- | μs |
| PWM Switching Frequency, $T_J \leq 150^\circ C$ | f_{PWM} | -- | 15 | -- | kHz |

ELECTRICAL CHARACTERISTICS (Unless specified particularly $T_{amb}=25^\circ C, V_{CC}=V_{BS}=15V$)

Inverter Part (Each fast recovery MOSFET Unless Otherwise Specified)

| Characteristics | Symbol | Test Conditions | Min | Typ | Max | Unit |
|------------------------------------|--------------|--|-----|-----|-----|----------|
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{IN}=0V, I_D=250\mu A$ (Note 2) | 500 | -- | -- | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{IN}=0V, V_{DS}=500V$ | -- | -- | 250 | μA |
| Static Drain-Source On-Resistance | $R_{DS(on)}$ | $V_{CC}=V_{BS}=15V, V_{IN}=5V, I_D=1.0A$ | -- | 3.0 | 4.0 | Ω |
| Drain-Source Diode Forward Voltage | V_{SD} | $V_{CC}=V_{BS}=15V, V_{IN}=0V, I_D=-1.0A$ | -- | -- | 1.2 | V |
| Switching Time | t_{ON} | $V_{PN} = 300V, V_{CC} = V_{BS} = 15V,$ $I_D = 0.5A, V_{IN} = 0V \sim 5V,$ Inductive load (Note 3) | -- | 700 | -- | ns |
| | t_{OFF} | | -- | 500 | -- | ns |
| | t_{rr} | | -- | 80 | -- | ns |
| | E_{ON} | | -- | 70 | -- | μJ |
| | E_{OFF} | | -- | 10 | -- | μJ |

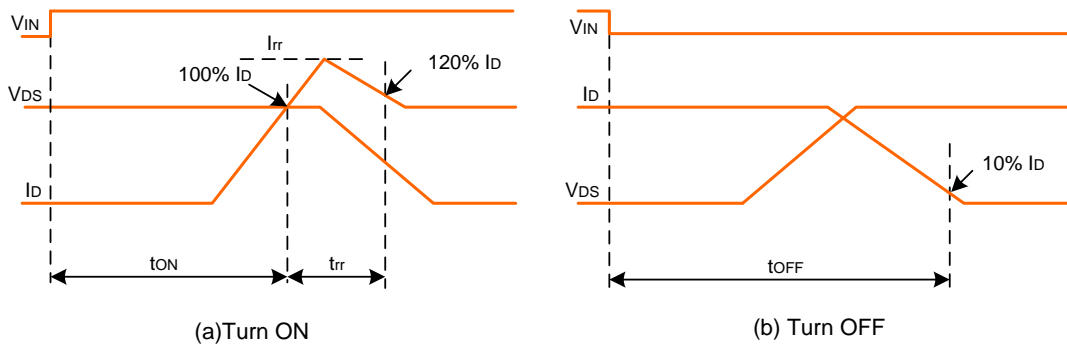


Figure 1. Switching Time Definition

Control Part (Each HVIC Unless Otherwise Specified)

| Characteristics | Symbol | Test Conditions | | Min | Typ | Max | Unit |
|---|------------|-------------------------------|---|-----|-----|------|---------|
| Quiescent VCC Current | I_{QCC} | $V_{CC}=15V$, $V_{IN}=0V$ | Between V_{CC} and COM | -- | -- | 160 | μA |
| Quiescent VBS Current | I_{QBS} | $V_{BS}=15V$, $V_{IN}=0V$ | Between $V_{B(U)-U}$, $V_{B(V)-V}$, $V_{B(W)-W}$ | -- | -- | 100 | μA |
| Low-side Undervoltage Protection (Figure 5) | UV_{CCD} | Detection Level | | 7.6 | 8.6 | 9.6 | V |
| | UV_{CCR} | Reset Level | | 8.3 | 9.3 | 10.3 | V |
| High-side Undervoltage Protection (Figure 6) | UV_{BSD} | Detection Level | | 7.6 | 8.6 | 9.6 | V |
| | UV_{BSR} | Reset Level | | 8.3 | 9.3 | 10.3 | V |
| ON Threshold Voltage | V_{IH} | Logic High Level | Applied between IN and COM | 3.0 | -- | -- | V |
| OFF Threshold Voltage | V_{IL} | Logic Low Level | | -- | -- | 0.8 | V |
| Input Bias Current | I_{IH} | $V_{IN}=5V$ | Applied between IN and COM | -- | 10 | 20 | μA |
| | I_{IL} | $V_{IN}=0V$ | | -- | -- | 2 | μA |

Note 2: BV_{DSS} is the maximum voltage applied to source-drain of each MOSFET. V_{PN} should be less than this value considering the effect of the stray inductance so that V_{DS} should not exceed BV_{DSS} in any case.

Note 3: t_{ON} and t_{OFF} consist of IC driving transmission delay. The value listed is tested under laboratory condition, and this value will change due to different PCB and wire. Please refer to switching time definition in figure 1 and switch test circuit in figure 4.

Note 4: Spike current and voltage of each MOSFET should be contained in SOA during switch operation, RBSOA test current is shown in figure 4.

Bootstrap Diode Part(Each Bootstrap diode Unless Otherwise Specified)

| Characteristics | Symbol | Test Conditions | Min | Typ | Max | Unit |
|-----------------------|----------|-------------------------------|-----|-----|-----|------|
| Forward Voltage | V_F | $I_F=0.1A$, $T_C=25^\circ C$ | -- | 2.5 | -- | V |
| Reverse Recovery Time | t_{rr} | $I_F=0.1A$, $T_C=25^\circ C$ | -- | 80 | -- | ns |

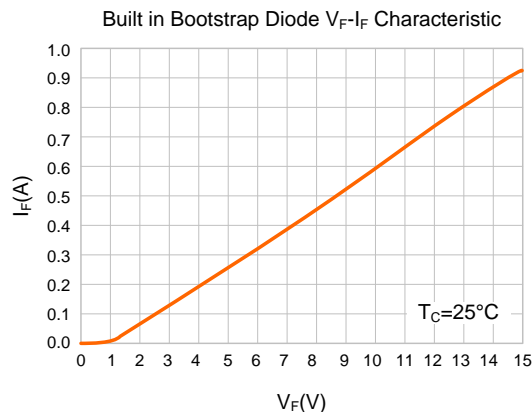
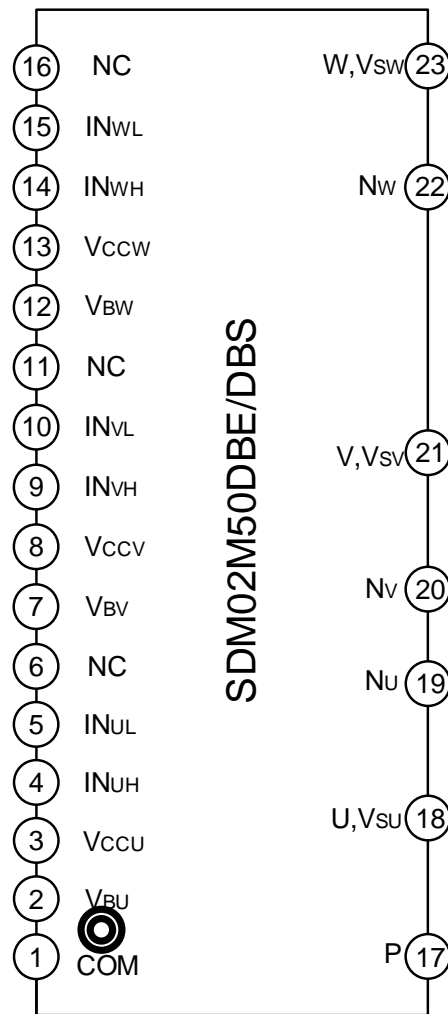


Figure 2. Bootstrap Diode resistor characteristic

Note: Resistive characteristic: equivalent resistor: $\sim 15 \Omega$.

PIN CONFIGURATIONS



PIN DESCRIPTIONS

| Pin No | Pin Name | Description |
|--------|------------------|--|
| 1 | COM | Common Supply Ground |
| 2 | V _{BU} | Bias Voltage for U Phase High Side Driving |
| 3 | V _{CCU} | Bias Voltage for U Phase Low Side Driving |
| 4 | IN _{UH} | Signal Input for U Phase High-side |
| 5 | IN _{UL} | Signal Input for U Phase Low-side |
| 6 | NC | No connection |
| 7 | V _{BV} | Bias Voltage for V Phase High Side Driving |
| 8 | V _{CCV} | Bias Voltage for V Phase Low Side Driving |
| 9 | IN _{VH} | Signal Input for V Phase High-side |
| 10 | IN _{VL} | Signal Input for V Phase Low-side |
| 11 | NC | No connection |
| 12 | V _{BW} | Bias Voltage for W Phase High Side Driving |

| Pin No | Pin Name | Description |
|--------|-------------------|--|
| 13 | V _{CCW} | Bias Voltage for W Phase Low Side Driving |
| 14 | IN _{WH} | Signal Input for W Phase High-side |
| 15 | IN _{WL} | Signal Input for W Phase Low-side |
| 16 | NC | No connection |
| 17 | P | Positive DC-Link Input |
| 18 | U,V _{SU} | Output for U Phase and Bias Voltage Ground for U Phase High Side Driving |
| 19 | NU | Negative DC-Link Input for U Phase |
| 20 | NV | Negative DC-Link Input for V Phase |
| 21 | V,V _{SV} | Output for V Phase and Bias Voltage Ground for V Phase High Side Driving |
| 22 | NW | Negative DC-Link Input for W Phase |
| 23 | W,V _{SW} | Output for W Phase and Bias Voltage Ground for W Phase High Side Driving |

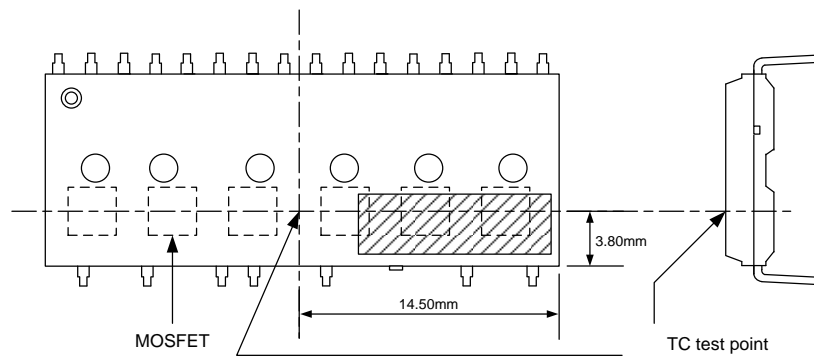


Figure 3. Case temperature TC test point

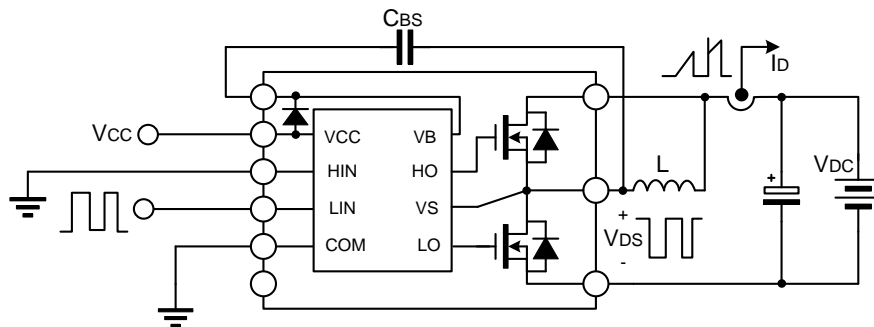


Figure 4. Switching and RBSOA Test Circuit(Low-side)

CONTROL TIME SEQUENCE

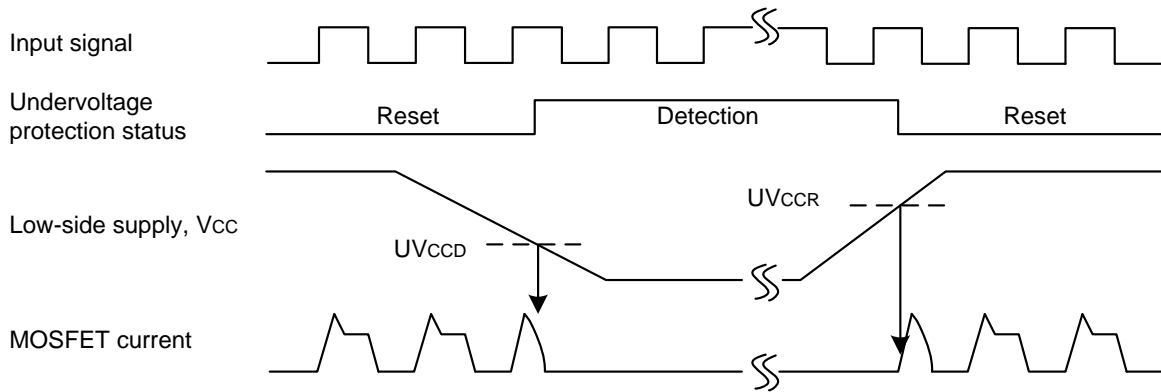


Figure 5. Under-Voltage Protection(Low side)

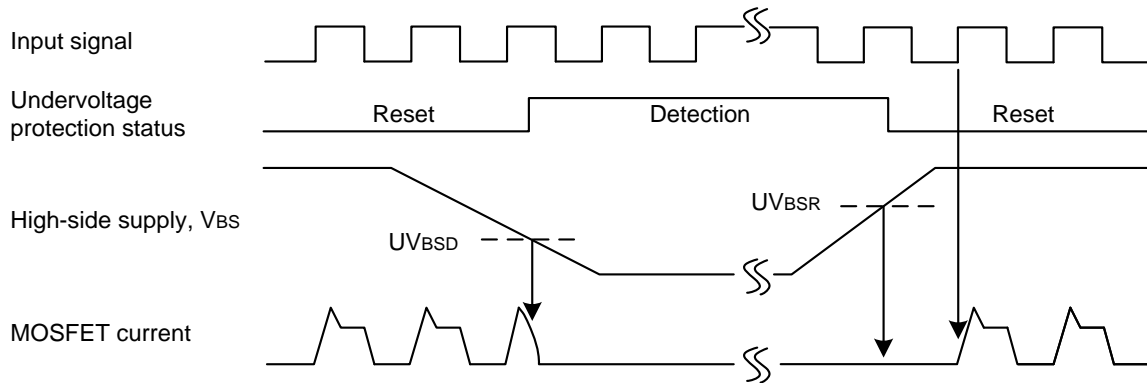
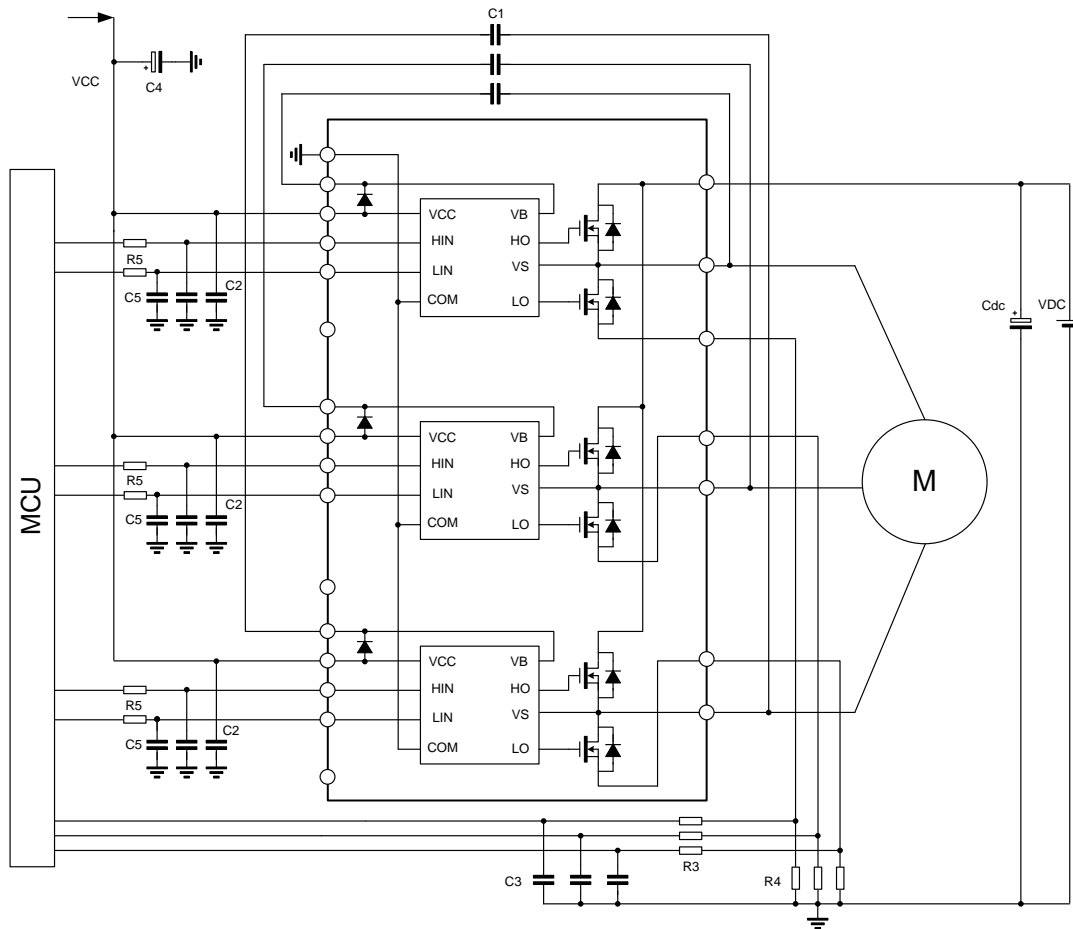


Figure 6. Under-Voltage Protection(High side)

TYPICAL APPLICATION CIRCUIT



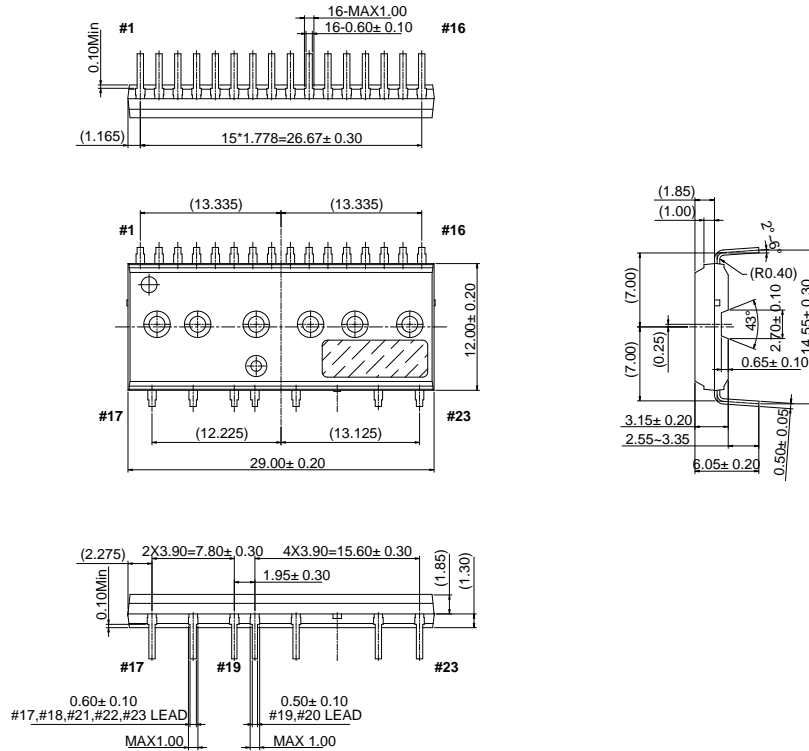
Note:

- (1) The wire of each pins should be as short as possible to avoid malfunction; RC filtering capacitor maybe connected to inputs to prevent surge noise caused by wrong input signal.
- (2) Each external capacitor should be placed as close as to IPM pin.
- (3) It is recommended to connect high frequency non-inductive capacitor besides filtering capacitor between PN with short wire to avoid surge destruction.
- (4) Better to connect a filtering capacitor which is 7 times larger than bootstrap capacitor C1 to VCC input.
- (5) It is recommended to adopt high frequency capacitor C1, whose value is larger than 2.2uF, as bootstrap capacitor to adsorb high frequency ripple.
- (6) The wire between current limit resistor R4 and IPM should be as short as possible to avoid IPM damage caused by surge voltage due to wire inductance.

PACKAGE OUTLINE

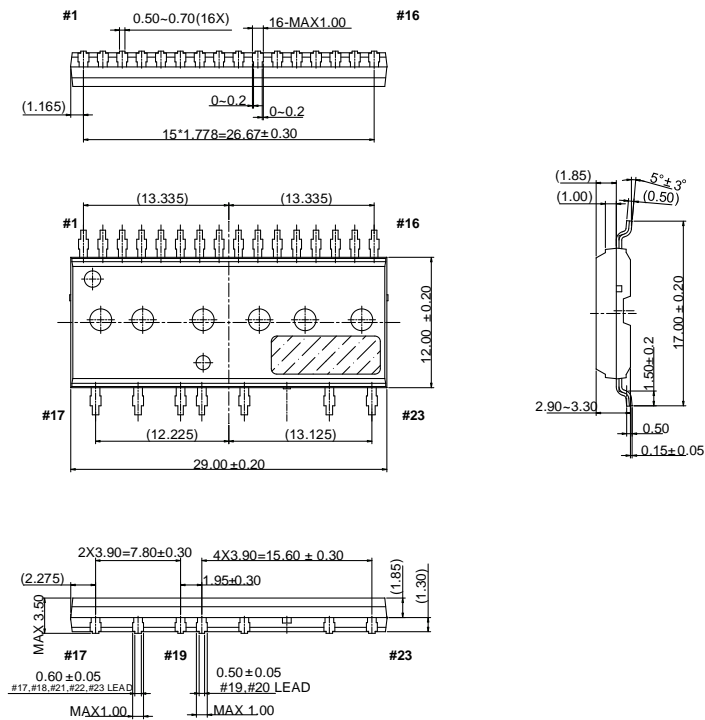
DIP-23E

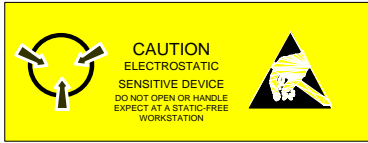
UNIT: mm



SOP-23H

UNIT: mm





MOS DEVICES OPERATE NOTES:

Electrostatic charges may exist in many things. Please take following preventive measures to prevent effectively the MOS electric circuit as a result of the damage which is caused by discharge:

- The operator must put on wrist strap which should be earthed to against electrostatic.
- Equipment cases should be earthed.
- All tools used during assembly, including soldering tools and solder baths, must be earthed.
- MOS devices should be packed in antistatic/conductive containers for transportation.

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Rev.: **1.1**

Revision History:

1. Modify pin configurations name annotation direction
 2. Update important notice
-

Rev.: **1.0**

Revision History:

1. First release
-